

## CeraLink

Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

Series/Type: Ordering code: B58035U\*

2019-09-25 Date:

Version: 6.2

<sup>©</sup> TDK Electronics AG 2019. Reproduction, publication and dissemination of this publication, enclosures hereto and the information contained therein without TDK Electronics' prior express consent is prohibited.



#### Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

## **Applications**

- Power converters and inverters
- DC link/snubber capacitor for power converters and inverters

#### **Features**

- High ripple current capability
- High temperature robustness
- Low equivalent serial inductance (ESL)
- Low equivalent serial resistance (ESR)
- Low power loss
- Low dielectric absorption
- Optimized for high frequencies up to several MHz
- Increasing capacitance with DC bias up to operating voltage
- High capacitance density
- Minimized dielectric loss at high temperatures
- Qualification based on AEC-Q200 rev. D
- Suitable for reflow soldering only

#### Construction

- RoHS-compatible PLZT ceramic (lead lanthanum zirconium titanate)
- Copper inner electrodes
- Silver outer electrodes
- Silver coated copper-invar lead frame
- Epoxy resin adhesive

#### General technical data

Dissipation factor	$\tan \delta$	< 0.02	
Insulation resistance	R <sub>ins, typ</sub> 1)	> 0.1	GΩ
Operating device temperature	T <sub>device</sub>	-40 +150	°C

 $<sup>^{1)}</sup>$  Typical insulation resistance, measured at operating voltage  $V_{op}$  and measurement time > 240s, +25  $^{\circ}$ C





## Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

## Overview of available types

		V <sub>R</sub> (V <sub>DC</sub> )			
		500	700	900	
	0.5			FA2	
	0.75			FA3	
	1		FA2		
(µF)	1.5		FA3		
C <sub>nom, typ</sub> (µF)	2	FA2			
Cnon	2.5			FA10	
	3	FA3			
	5		FA10		
	10	FA10			

## **Electrical specifications and ordering codes**

Туре	V <sub>pk, max</sub>	V <sub>R</sub>	V <sub>op</sub>	C <sub>nom, typ</sub> µF	C <sub>eff</sub> µF	C₀ µF	Ordering code
FA2	650	500	400	2	1.20 ±20%	0.70 ±20%	B58035U5205M062 B58035U5205M052 *)
FA3	650	500	400	3	1.80 ±20%	1.05 ±20%	B58035U5305M062 B58035U5305M052 *)
FA10	650	500	400	10	6.00 ±20%	3.50 ±20%	B58035U5106M001
FA2	1000	700	600	1	0.50 ±20%	0.28 ±20%	B58035U7105M062 B58035U7105M052 *)
FA3	1000	700	600	1.5	0.75 ±20%	0.42 ±20%	B58035U7155M062 B58035U7155M052 *)
FA10	1000	700	600	5	2.50 ±20%	1.40 ±20%	B58035U7505M001
FA2	1300	900	800	0.5	0.26 ±20%	0.14 ±20%	B58035U9504M062 B58035U9504M052 *)
FA3	1300	900	800	0.75	0.39 ±20%	0.21 ±20%	B58035U9754M062 B58035U9754M052 *)
FA10	1300	900	800	2.5	1.30 ±20%	0.70 ±20%	B58035U9255M001

<sup>\*)</sup> smaller packaging unit (180-mm reel), see section "Packaging" for details



## Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

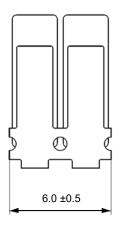
Typical values as a design reference for CeraLink® applications

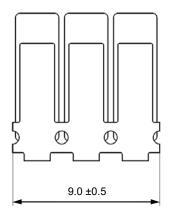
	JPIGGI	Talacc	40 4 40	<u> </u>	1100 101 001	<u> </u>	ppnoations	
	Туре	V <sub>R</sub>	Weight G	ESR 0 V <sub>DC</sub> , 0.5 V <sub>RMS</sub> , 25°C, 1kHz <b>Ω</b>	ESR 0 V <sub>DC</sub> , 0.5 V <sub>RMS</sub> , 25°C, 1MHz <b>m</b> Ω	nH	I <sub>op</sub> 1) 100 kHz, T <sub>A</sub> = 85°C	I <sub>op</sub> <sup>1)</sup> 100 kHz, T <sub>A</sub> = 105°C
_	FA2	500	2.3	3	5	3	17	14
_	FA3	500	3.5	2	4	3	20	17
_	FA10	500	11.5	1	3	2	47	38
_	FA2	700	2.3	6	17	3	12	11
_	FA3	700	3.5	4	12	3	16	13
_	FA10	700	11.5	1	5	2	39	30
_	FA2	900	2.3	11	29	3	8	7
_	FA3	900	3.5	7	20	3	11	9
_	FA10	900	11.5	2	7	2	32	23

 $<sup>^{1)}</sup>$  Normal operating current without forced cooling at  $T_{\text{device}}$  = +150 °C. Higher values permissible at reduced lifetime.

## **Dimensional drawings**

FA 2 FA 3



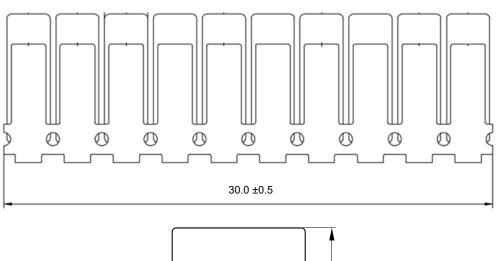


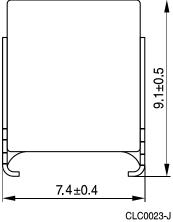


## Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

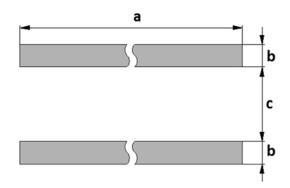
**FA 10** 





Dimensions in mm

## Recommended solder pads



Туре	а	b	С
FA2	7	2.85	5
FA3	10	2.85	5
FA10	31	2.85	5

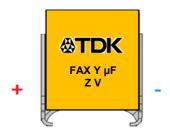
Dimensions in mm



#### Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

## Polarity and marking of components



Manufacturer's logo

X = CeraLink FA type (e.g. FA2)

Y = Nominal capacitance

Z = Rated voltage

Note that polarity is only for incoming inspection purposes and it does not affect operation. If put under reverse rated voltage  $V_R$ , CeraLink is repoled and works identically.



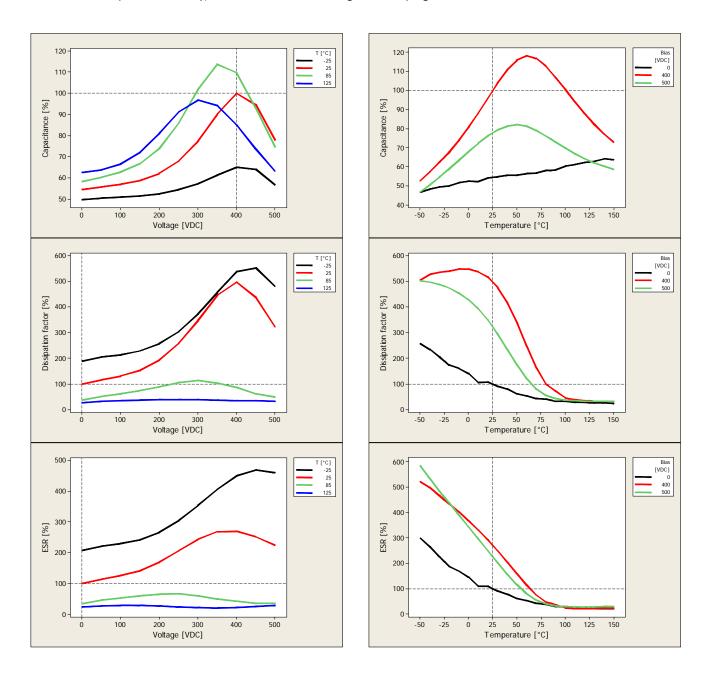
## Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

# Typical characteristics as a function of temperature and voltage $V_R$ = 500 V ( $V_{AC}$ = 0.5 $V_{RMS}$ , frequency = 1 kHz)

All given temperatures are device temperatures.

The curves show the relative changes of the capacitance, dissipation factor and ESR. The 100% values correspond to  $C_{\text{eff, typ}}$  and tan  $\delta$  which are given on pages 2, 3 and 4 of this data sheet.





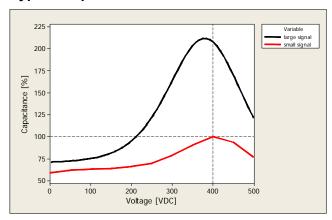
#### Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

## **Application Notes**

Further typical electrical characteristics as a design reference for CeraLink applications.

## Typical capacitance values as a function of voltage $V_R$ = 500 V – valid for FA2, FA3 and FA10



Large signal capacitance:

Quasistatic (slow variation of the voltage), +25 °C

The nominal capacitance is defined as the large signal capacitance at  $V_{\text{op}}$ .

See glossary for further information.

Small signal capacitance:

0.5 V<sub>RMS</sub>, 1 kHz, +25 °C

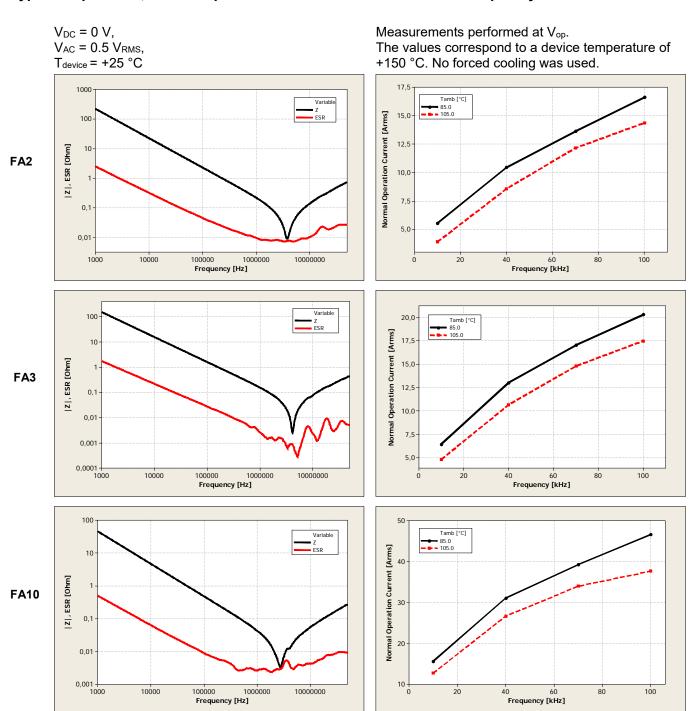
The effective capacitance is defined as the small signal capacitance at  $V_{\text{op}}$ .



#### Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

#### Typical impedance, ESR and permissible current as a function of frequency V<sub>R</sub> = 500 V



#### **Aaina**

The capacitance has an aging behavior which shows a decrease of capacitance with time.

The typical aging rate is about 2.5% per logarithmic decade in hours.



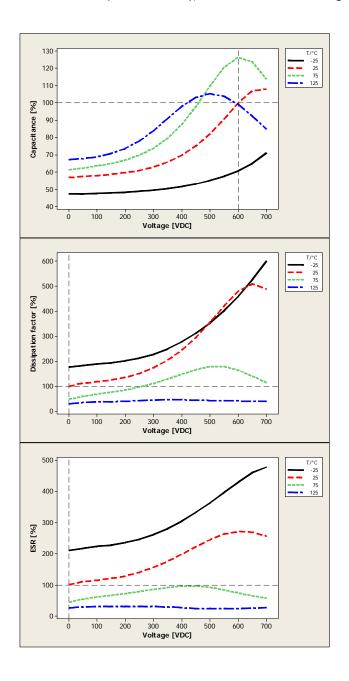
## Capacitor for fast-switching semiconductors

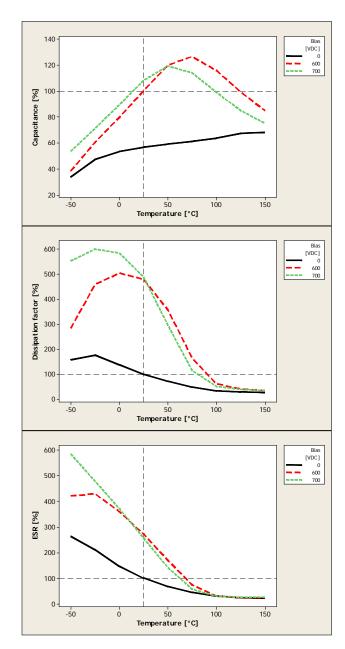
Flex Assembly (FA) series

# Typical characteristics as a function of temperature and voltage $V_R$ = 700 V ( $V_{AC}$ = 0.5 $V_{RMS}$ , frequency = 1 kHz)

All given temperatures are device temperatures.

The curves show the relative changes of the capacitance, dissipation factor and ESR. The 100% values correspond to  $C_{\text{eff, typ}}$  and tan  $\delta$  which are given on pages 2, 3 and 4 of this data sheet.







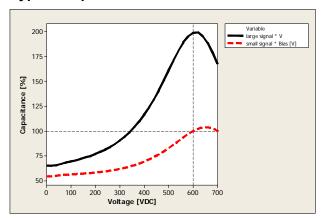
### Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

## **Application Notes**

Further typical electrical characteristics as a design reference for CeraLink applications.

#### Typical capacitance values as a function of voltage $V_R = 700 \text{ V}$ – valid for FA2, FA3 and FA10



Large signal capacitance:

Quasistatic (slow variation of the voltage), +25 °C

The nominal capacitance is defined as the large signal capacitance at  $V_{\text{op}}$ .

See glossary for further information.

Small signal capacitance:

0.5 V<sub>RMS</sub>, 1 kHz, +25 °C

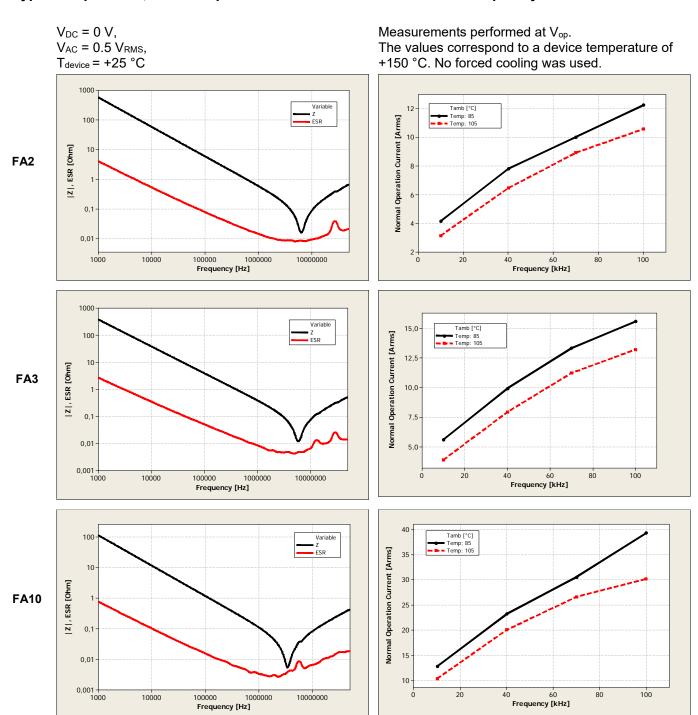
The effective capacitance is defined as the small signal capacitance at  $V_{\text{op}}$ .



#### Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

#### Typical impedance, ESR and permissible current as a function of frequency V<sub>R</sub> = 700 V



#### **Aging**

The capacitance has an aging behavior which shows a decrease of capacitance with time.

The typical aging rate is about 2.5% per logarithmic decade in hours.



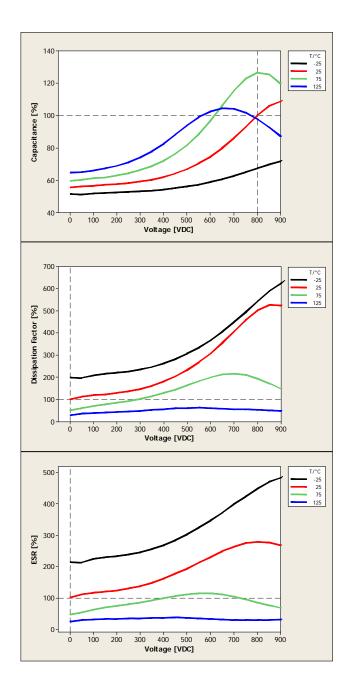
#### Capacitor for fast-switching semiconductors

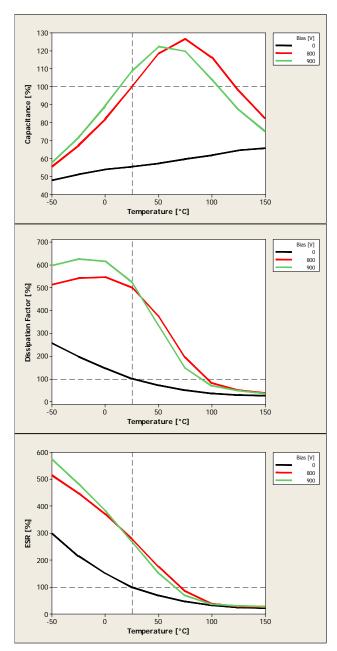
Flex Assembly (FA) series

# Typical characteristics as a function of temperature and voltage $V_R$ = 900 V ( $V_{AC}$ = 0.5 $V_{RMS}$ , frequency = 1 kHz)

All given temperatures are device temperatures.

The curves show the relative changes of the capacitance, dissipation factor and ESR. The 100% values correspond to  $C_{\text{eff, typ}}$  and tan  $\delta$  which are given on pages 2, 3 and 4 of this data sheet.







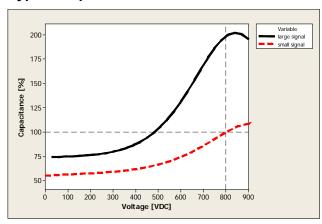
#### Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

## **Application Notes**

Further typical electrical characteristics as a design reference for CeraLink applications.

#### Typical capacitance values as a function of voltage $V_R$ = 900 V – valid for FA2, FA3 and FA10



Large signal capacitance:

Quasistatic (slow variation of the voltage), +25 °C

The nominal capacitance is defined as the large signal capacitance at  $V_{\text{op}}$ .

See glossary for further information.

Small signal capacitance:

0.5 V<sub>RMS</sub>, 1 kHz, +25 °C

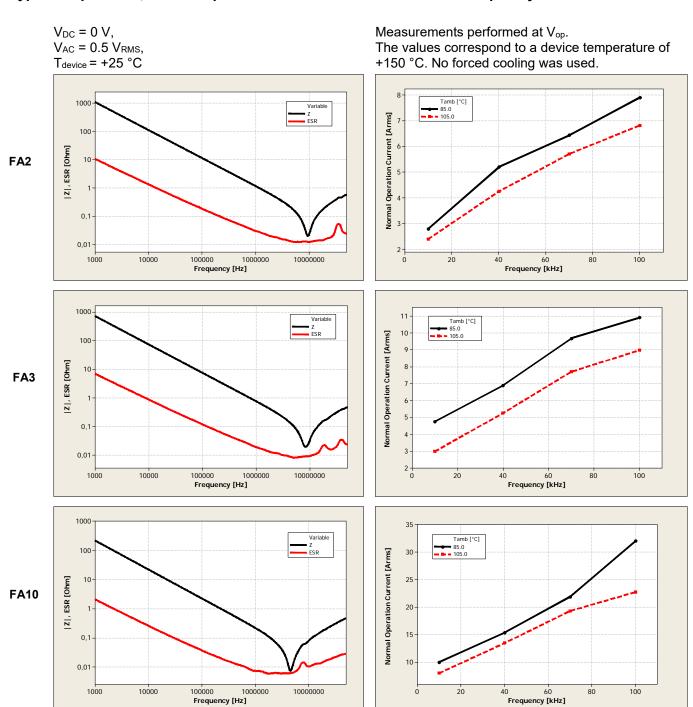
The effective capacitance is defined as the small signal capacitance at  $V_{\text{op}}$ .



#### Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

#### Typical impedance, ESR and permissible current as a function of frequency V<sub>R</sub> = 900 V



#### **Aging**

The capacitance has an aging behavior which shows a decrease of capacitance with time.

The typical aging rate is about 2.5% per logarithmic decade in hours.



#### Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

Criteria

defined limits

defined limits

No detaching of termination. No rupture of ceramic

 $|\Delta C_0/C_0|$ , tan  $\delta$  and  $R_{ins}$  within

## Reliability

- A. Preconditioning:
- Reflow solder the capacitor on a PCB using the recommended soldering profile
- Check of external appearance
- Measurement of electrical parameters  $R_{ins}$ ,  $C_0$ , tan  $\delta$ 
  - Apply V<sub>pk,max</sub> for 7 seconds and measure R<sub>ins</sub> at room temperature:  $R_{ins} > 100 M\Omega$ Isolation resistance (@ V<sub>pk,max</sub>, 7 s, 25 °C)

Measure  $C_0$  and tan  $\delta$  within 10 minutes to 1 hour afterwards: Initial capacitance (@ 0 V<sub>DC</sub>, 0.5 V<sub>RMS</sub>, 1 kHz, 25 °C) Dissipation factor (@ 0 V<sub>DC</sub>, 0.5 V<sub>RMS</sub>, 1 kHz, 25 °C)

- B. Performance of a specific reliability test.
- C. After performing a specific test:
- Check the external appearance again
- Repeat the measurement of the electrical parameters
  - Apply V<sub>pk,max</sub> for 7 seconds and measure R<sub>ins</sub> at room temperature: Isolation resistance (@ V<sub>pk,max</sub>, 7 s, 25 °C)  $R_{ins} > 10 M\Omega$
  - Measure C and tan  $\delta$ :

Standard

AEC-Q200-005

Test

Terminal

strength test

Change of initial capacitance (@ 0 V<sub>DC</sub>, 0.5 V<sub>RMS</sub>, 1 kHz, 25 °C)

Test conditions

1000 cycles

 $|\Delta C_0 / C_0| < 15\%$ Dissipation factor (@ 0 V<sub>DC</sub>, 0.5 V<sub>RMS</sub>, 1 kHz, 25 °C)  $\tan \delta < 0.05$ 

1031	Otandard	1 CSt Containons	Officia
External appearance		Visual inspection with magnifying glass	No defects that might affect performance
High temperature operating life	MIL-STD-202, method 108	+150 °C, V <sub>R</sub> , 1000 hours	No mechanical damage $ \Delta C_0/C_0 $ , tan $\delta$ and $R_{ins}$ within defined limits
Biased humidity	MIL-STD-202, method 103	+85 °C, 85% rel. hum., V <sub>R</sub> , 1000 hours	No mechanical damage $ \Delta C_0/C_0 $ , tan $\delta$ and $R_{ins}$ within defined limits
Temperature shock	IEC 60384-9, 4.8	-55 °C to +150 °C 20 seconds transfer time 15 minutes dwell time	No mechanical damage $ \Delta C_0/C_0 $ , tan $\delta$ and $R_{ins}$ within

Apply a force of 17.7 N for 60 seconds

Pushing force

P.C.Board



## Capacitor for fast-switching semiconductors

## Flex Assembly (FA) series

Test	Standard	Test conditions	Criteria	
Board flex	AEC-Q200-005	Bending of 2 mm for 60 seconds  Support Solder Chip Printed circuit board before testing  45±2 KEZESZ-M  Printed circuit board under test  Displacement  Dimensions in mm	No mechanical damage $ \Delta C_0 / C_0 $ , tan $\delta$ and $R_{\text{ins}}$ within defined limits	
Vibration	MIL-STD-202, method 204	5 g/ 20 min, 12 cycles, 3 axis 10 Hz to 2000 Hz	No mechanical damage $ \Delta C_0/C_0 $ , tan $\delta$ and $R_{ins}$ within defined limits	
Mechanical shock	MIL-STD-202, method 213	Acceleration 400 m/s² Half sine pulse duration 6 milliseconds 4000 bumps	No mechanical damage $ \Delta C_0 / C_0 $ , tan $\delta$ and $R_{ins}$ within defined limits	
Reflow test		3 times recommended reflow soldering profile	No mechanical damage Proper solder coating of contact areas $ \Delta C_0/C_0 $ , tan $\delta$ and $R_{ins}$ within defined limits	
Leaching test (lead frame only)	MIL-STD-202, method 210, condition B	Dip test of contact areas in solder bath (+260 °C for 10 seconds)	No damage of lead frame silver coating	
Solderability (lead frame only)	J-STD-002, method A @ +235 °C, category 3	Dip test of contact areas in solder bath +(235 °C for 5 ± 0.5 seconds)	> 95% wettability of lead frame	
Resistance to solvent		Dipping and cleaning with isopropanol	Marking must be legible $ \Delta C_0/C_0 $ , tan $\delta$ and $R_{ins}$ within defined limits	
Geometry		Using a caliper	Within specified tolerance in the chapter construction	



#### Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

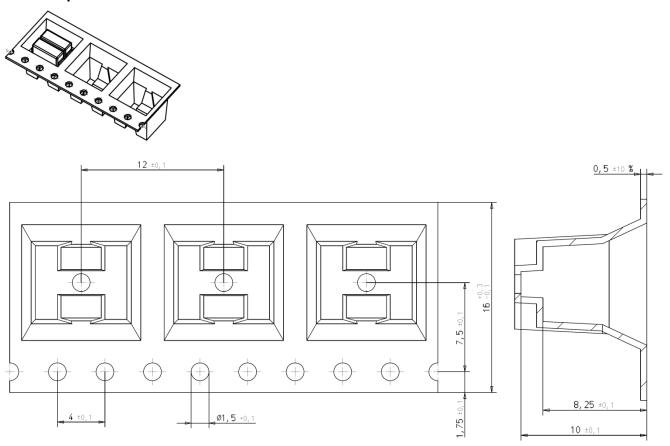
## **Packaging**

The CeraLink FA2 type is delivered in a blister tape (taping to IEC 60286-3, 180-mm / 330-mm reel available with 110 / 500 pieces per reel).

The CeraLink FA3 type is delivered in a blister tape (taping to IEC 60286-3, 180-mm / 330-mm reel available with 100 / 350 pieces per reel).

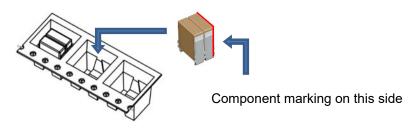
The CeraLink FA10 type is delivered in a cardboard box with 100 pieces per box.

#### Blister tape for FA2



#### Part orientation

The part-orientation/polarity is the same for all CeraLink FA2 capacitors within the blister tape.

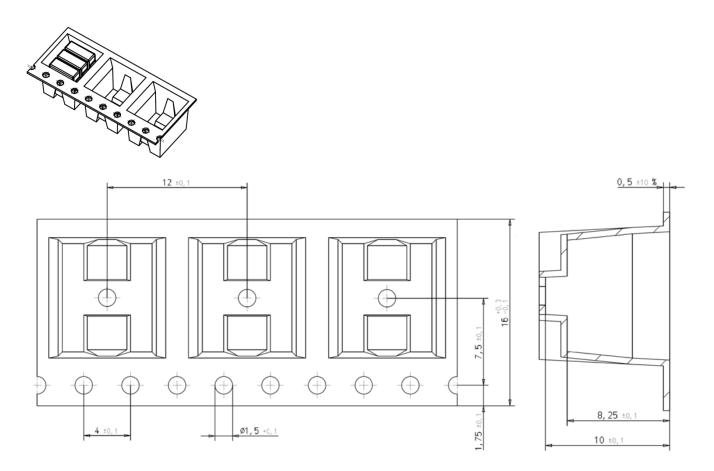




## Capacitor for fast-switching semiconductors

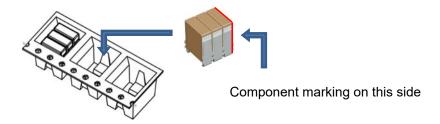
Flex Assembly (FA) series

#### Blister tape for FA3



#### Part orientation

The part-orientation/polarity is the same for all CeraLink FA3 capacitors within the blister tape.





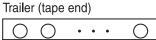
## Capacitor for fast-switching semiconductors

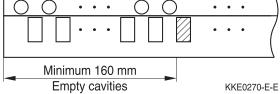
Flex Assembly (FA) series

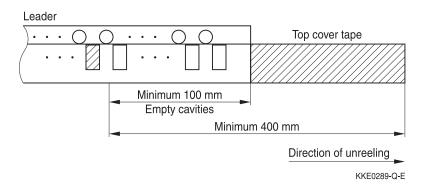
#### **Taping information**

Trailer: There is a minimum of 160 mm of carrier tape with empty compartments and sealed by the cover tape.

Leader: There is a minimum of 400 mm of cover tape, which includes at least 100 mm of carrier tape with empty compartments.

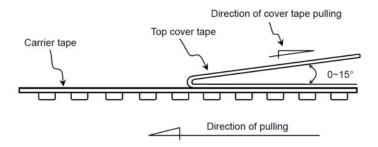






#### Fixing peeling strength (top tape)

The peeling strength is 0.1 ... 1.3 N.

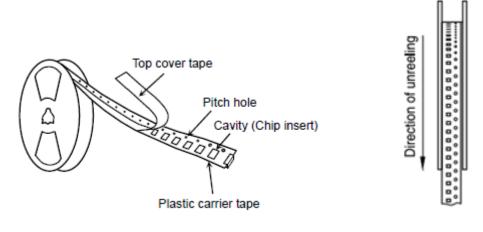


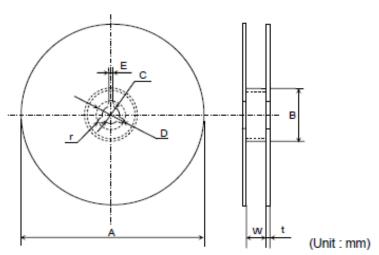


## Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

#### Reel packing





	FA2 & FA3 Type 330-mm reel	FA2 & FA3 Type 180-mm reel
A	330 ±2	180 ±3
В	62 ±1	62 ±1
С	12.8 +0.7	13.1 ±0.5
D	19.1 min.	19.1 min.
E	1.6 ±0.5	2.1 ±0.5
W	16.4 +2	17.0 -0.5 / +2

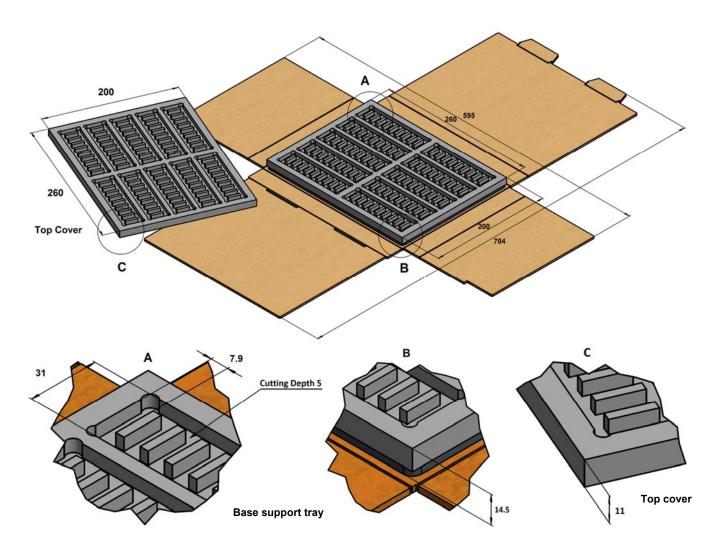
Dimensions in mm



## Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

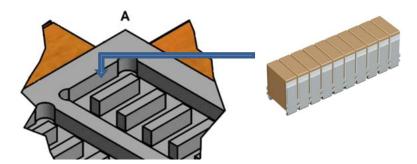
#### Cardboard box for FA10



Dimensions in mm

#### Part orientation

The part-orientation/polarity is the same for all CeraLink FA10 capacitors within the tray. Parts are placed with leadframes facing base support tray as shown.

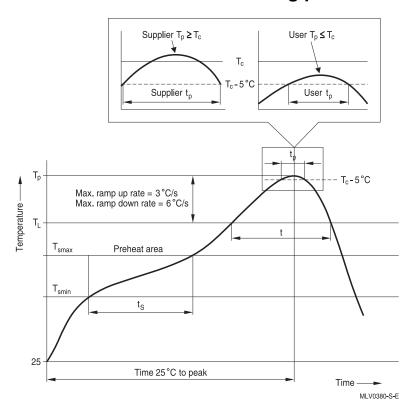




## Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

## Recommended reflow soldering profile



Profile feature		SAC, Sn95.5Ag3.8Cu0.7 @ N <sub>2</sub> atmosphere
Preheat and soak		
- Temperature min	T <sub>smin</sub>	+150 °C
- Temperature max	T <sub>smax</sub>	+200 °C
- Time	t <sub>smin</sub> to t <sub>smax</sub>	60 120 seconds
Average ramp-up rate	T <sub>L</sub> to T <sub>p</sub>	3 °C/ second max.
Liquidus temperature	TL	+217 °C
Time at liquidus temperature	t∟	60 150 seconds
Peak package body temperature	T <sub>p</sub> <sup>1)</sup>	245 °C 260 °C max. <sup>2)</sup>
Time (t <sub>p</sub> ) <sup>3)</sup> within +5 °C of specified		30 seconds <sup>3)</sup>
classification temperature (Tc)		
Average ramp-down rate	T <sub>p</sub> to T <sub>L</sub>	+6 °C/ second max.
Time +25 °C to peak temperature		maximum 8 minutes

- 1) Tolerance for peak profile temperature  $(T_p)$  is defined as a supplier minimum and a user maximum.
- 2) Depending on package thickness (cf. JEDEC J-STD-020D).
- 3) Tolerance for time at peak profile temperature (tp) is defined as a supplier minimum and a user maximum.

#### Notes:

All temperatures refer to topside of the package, measured on the package body surface.

Max. number of reflow cycles: 3

After the soldering process, the capacitance is lowered. Applying  $V_R$  to the device will re-establish the capacitance. The proposed soldering profile is based on IEC 60068-2-58 (respectively JEDEC J-STD-020D) recommendations



Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

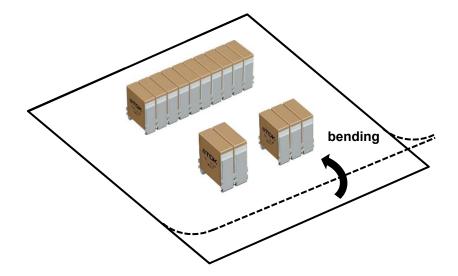
#### General technical information

#### Storage

- Only store CeraLink capacitors in their original packaging. Do not open the package prior to processing.
- Storage conditions in original packaging: temperature -25 °C to +45 °C, relative humidity ≤ 75% annual average, maximum 95%, dew precipitation is inadmissible.
- Do not store CeraLink capacitors where they are exposed to heat or direct sunlight. Otherwise the packaging material may be deformed or CeraLink may stick together, causing problems during mounting.
- Avoid contamination of the CeraLink surface during storage, handling and processing.
- Avoid storing CeraLink devices in harmful environments where they are exposed to corrosive gases (e.g. SOx, CI).
- Use CeraLink as soon as possible after opening factory seals such as polyvinyl-sealed packages.
- Solder CeraLink components within 6 months after shipment.

#### Handling

- Do not drop CeraLink components or allow them to be chipped.
- Do not clamp CeraLink components on the face sides (e.g. during pick-and-place). A vacuum-based pick-and-place process picking the component on the top side is recommended.
- Do not touch CeraLink with your bare hands gloves are recommended.
- Avoid contamination of the CeraLink surface during handling.
- The CeraLink FA series was tested to withstand the board flex test defined in the AEC-Q200 rev D, method 005.
- The CeraLink FA series uses copper-invar lead frames to prevent mechanical stress to the ceamic. Too much bending causes open mode. Avoid high mechanical stress like twisting after soldering on a PCB.





#### Capacitor for fast-switching semiconductors

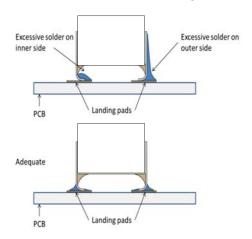
Flex Assembly (FA) series

### Mounting

- Do not subject CeraLink devices to mechanical stress when encapsulating them with sealing material or overmolding with plastic material. Encapsulation may lead to worse heat dissipation too. Please ask for further information.
- Do not scratch the electrodes before, during or after the mounting process.
- Make sure contacts and housings used for assembly with CeraLink components are clean before mounting.
- The surface temperature of an operating CeraLink can be higher than the ambient temperature. Ensure that adjacent components are placed at a sufficient distance from a CeraLink to allow proper cooling.
- Avoid contamination of the CeraLink surface during processing.

#### Soldering guidelines

- The use of mild, non-activated fluxes for soldering is recommended, as well as proper cleaning of the PCB.
- Complete removal of flux is recommended to avoid surface contamination that can result in an instable and/or high leakage current.
- Use resin-type or non-activated flux.
- Bear in mind that insufficient preheating may cause ceramic cracks.
- Rapid cooling by dipping in solvent is not recommended, otherwise a component may crack.
- Excessive usage of solder paste can reduce the mechanical robustness of the device, whereas insufficient solder may cause the CeraLink to detach from the PCB. Use an adequate amount of solder paste, but on the landing pads only.



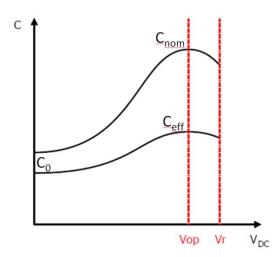
- If an unsuitable cleaning fluid is used, flux residue or foreign particles may stick to the CeraLink surface and deteriorate its insulation resistance. Insufficient or improper cleaning of the CeraLink may cause damage to the component.
- Excessive washing like ultrasonic cleaning, can affect the connection between the ceramic chip and the outer electrode. To avoid this, we give the following recommendation:
  - o Power: 20 W/I max.
  - o Frequency: 40 kHz max.
  - o Washing time: 5 minutes max.



#### Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

## **Glossary**



Initial capacitance  $C_0$ : Is the value at the origin of the hysteresis without any applied direct

voltage.

Effective capacitance  $C_{\text{eff}}$ : Occurs at  $V_{\text{op}}$  and is measured with an applied ripple voltage of

 $0.5 \, V_{\text{RMS}}$  and 1 kHz. The CeraLink is designed to have its highest

capacitance value at the operating voltage Vop.

Nominal capacitance C<sub>nom</sub>: Is the value derived by the tangent of the mean hysteresis as the

derivative of the mean hysteresis is dQ/dV ~ C.



### Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

## Symbols and terms

AC Alternating current

C<sub>0</sub> Initial capacitance @ 0 V<sub>DC</sub>, 0.5 V<sub>RMS</sub>, 1 kHz, +25 °C

C<sub>eff,typ</sub> Typical effective capacitance @ V<sub>op</sub>, 0.5 V<sub>RMS</sub>, 1 kHz, +25 °C

C<sub>nom,typ</sub> Typical nominal capacitance @ V<sub>op</sub>, quasistatic, +25 °C. See glossary for

definition of the nominal capacitance

DC Direct current

ESL Equivalent serial inductance
ESR Equivalent serial resistance

I<sub>op</sub> Operating ripple current, root mean square value of sinusoidal AC current

LP Low profile

PCB Printed circuit board

PLZT Lead lanthanum zirconium titanate

 $R_{ins}$  Insulation resistance @  $V_{pk,max}$ , measurement time t = 7 s, +25 °C R<sub>ins. tvp</sub> Insulation resistance @  $V_{op}$ , measurement time t > 240 s, +25 °C

SAC Tin silver copper alloy; lead-free solder paste

T<sub>amb</sub> Ambient temperature

tan  $\delta$  Dissipation factor @ 0  $V_{DC}$ , 0.5  $V_{RMS}$ , 1 kHz, +25°C

 $T_{\text{device}}$  Device temperature.  $T_{\text{device}} = T_{\text{amb}} + \Delta T$  ( $\Delta T$  defines the self-heating of the device

due to applied current).

 $V_{\text{op}}$  Operating voltage at maximum attenuation capability  $V_{\text{R}}$  Rated voltage. Reference DC voltage for reliability tests.

V<sub>RMS</sub> Root mean square value of sinusoidal AC voltage

V<sub>pk,max</sub> Maximum peak operating voltage

ΔT Increase of temperature during operation



### Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

## **Cautions and warnings**

#### General

Not for use in resonant circuits, where a voltage of alternating polarity occurs.

Not for AC applications. Consult our local representative for further details.

If used in snubber circuits, ensure that the sum of all voltages remains at the same polarity.

Some parts of this publication contain statements about the suitability of our CeraLink components for certain areas of application, including recommendations about incorporation/design-in of these products into customer applications. The statements are based on our knowledge of typical requirements often made of our CeraLink devices in the particular areas. We nevertheless expressly point out that such statements cannot be regarded as binding statements about the suitability of our CeraLink components for a particular customer application. As a rule, TDK is either unfamiliar with individual customer applications or less familiar with them than the customers themselves. For these reasons, it is always incumbent on the customer to check and decide whether the CeraLink devices with the properties described in the product specification are suitable for use in a particular customer application.

- Do not use CeraLink components for purposes not identified in our specifications.
- Ensure the suitability of a CeraLink in particular by testing it for reliability during design-in. Always evaluate a CeraLink component under worst-case conditions.
- Pay special attention to the reliability of CeraLink devices intended for use in safety-critical applications (e.g. medical equipment, automotive, spacecraft, nuclear power plant).

#### Design notes

- Consider derating at higher operating temperatures. As a rule, lower temperatures and voltages increase the life time of CeraLink devices.
- If steep surge current edges are to be expected, make sure your design is as low-inductive as possible.
- In some cases the malfunctioning of passive electronic components or failure before the end of their service life cannot be completely ruled out in the current state of the art, even if they are operated as specified. In applications requiring a very high level of operational safety and especially when the malfunction or failure of a passive electronic component could endanger human life or health (e.g. in accident prevention, life-saving systems, or automotive battery line applications such as clamp 30), ensure by suitable design of the application or other measures (e.g. installation of protective circuitry, fuse or redundancy) that no injury or damage is sustained by third parties in the event of such a malfunction or failure.
- Specified values only apply to CeraLink components that have not been subject to prior electrical, mechanical or thermal damage. The use of CeraLink devices in line-to-ground applications is therefore not advisable, and it is only allowed together with safety countermeasures such as thermal fuses.



### Capacitor for fast-switching semiconductors

Flex Assembly (FA) series

#### Operation

- Use CeraLink only within the specified operating temperature range.
- Use CeraLink only within specified voltage and current ranges.
- The CeraLink has to be operated in a dry atmosphere, which must not contain any additional chemical vapors or substances.
- Environmental conditions must not harm the CeraLink. Use the capacitors under normal atmospheric conditions only. A reduction of the oxygen partial pressure to below 1 mbar is not permissible.
- Prevent a CeraLink from contacting liquids and solvents.
- Avoid dewing and condensation.
- During operation, the CeraLink can produce audible noise due to its piezoelectric characteristic.
- CeraLink components are mainly designed for encased applications. Under all circumstances avoid exposure to:
  - o direct sunlight
  - o rain or condensation
  - o steam, saline spray
  - o corrosive gases
  - atmosphere with reduced oxygen content

This listing does not claim to be complete, but merely reflects the experience of the manufacturer.

#### Display of ordering codes for TDK Electronics products

The ordering code for one and the same product can be represented differently in data sheets, data books, other publications, on the company website, or in order-related documents such as shipping notes, order confirmations and product labels. The varying representations of the ordering codes are due to different processes employed and do not affect the specifications of the respective products. Detailed information can be found on the Internet under www.tdk-electronics.tdk.com/orderingcodes.

#### Important notes

The following applies to all products named in this publication:

- 1. Some parts of this publication contain statements about the suitability of our products for certain areas of application. These statements are based on our knowledge of typical requirements that are often placed on our products in the areas of application concerned. We nevertheless expressly point out that such statements cannot be regarded as binding statements about the suitability of our products for a particular customer application. As a rule we are either unfamiliar with individual customer applications or less familiar with them than the customers themselves. For these reasons, it is always ultimately incumbent on the customer to check and decide whether a product with the properties described in the product specification is suitable for use in a particular customer application.
- 2. We also point out that in individual cases, a malfunction of electronic components or failure before the end of their usual service life cannot be completely ruled out in the current state of the art, even if they are operated as specified. In customer applications requiring a very high level of operational safety and especially in customer applications in which the malfunction or failure of an electronic component could endanger human life or health (e.g. in accident prevention or life-saving systems), it must therefore be ensured by means of suitable design of the customer application or other action taken by the customer (e.g. installation of protective circuitry or redundancy) that no injury or damage is sustained by third parties in the event of malfunction or failure of an electronic component.
- 3. The warnings, cautions and product-specific notes must be observed.
- 4. In order to satisfy certain technical requirements, some of the products described in this publication may contain substances subject to restrictions in certain jurisdictions (e.g. because they are classed as hazardous). Useful information on this will be found in our Material Data Sheets on the Internet (www.tdk-electronics.tdk.com/material). Should you have any more detailed questions, please contact our sales offices.
- 5. We constantly strive to improve our products. Consequently, **the products described in this publication may change from time to time**. The same is true of the corresponding product specifications. Please check therefore to what extent product descriptions and specifications contained in this publication are still applicable before or when you place an order.
  - We also **reserve the right to discontinue production and delivery of products**. Consequently, we cannot guarantee that all products named in this publication will always be available. The aforementioned does not apply in the case of individual agreements deviating from the foregoing for customer-specific products.
- 6. Unless otherwise agreed in individual contracts, all orders are subject to our General Terms and Conditions of Supply.
- 7. Our manufacturing sites serving the automotive business apply the IATF 16949 standard. The IATF certifications confirm our compliance with requirements regarding the quality management system in the automotive industry. Referring to customer requirements and customer specific requirements ("CSR") TDK always has and will continue to have the policy of respecting individual agreements. Even if IATF 16949 may appear to support the acceptance of unilateral requirements, we hereby like to emphasize that only requirements mutually agreed upon can and will be implemented in our Quality Management System. For clarification purposes we like to point out that obligations from IATF 16949 shall only become legally binding if individually agreed upon.



#### Important notes

8. The trade names EPCOS, CeraCharge, CeraDiode, CeraLink, CeraPad, CeraPlas, CSMP, CTVS, DeltaCap, DigiSiMic, ExoCore, FilterCap, FormFit, LeaXield, MiniBlue, MiniCell, MKD, MKK, MotorCap, PCC, PhaseCap, PhaseCube, PhaseMod, PhiCap, PowerHap, PQSine, PQvar, SIFERRIT, SIFI, SIKOREL, SilverCap, SIMDAD, SiMic, SIMID, SineFormer, SIOV, ThermoFuse, WindCap are **trademarks registered or pending** in Europe and in other countries. Further information will be found on the Internet at www.tdk-electronics.tdk.com/trademarks.

Release 2018-10

## **Mouser Electronics**

**Authorized Distributor** 

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

## **EPCOS / TDK:**

<u>B58035U9255M001</u> <u>B58035U7505M001</u> <u>B58035U5106M001</u> <u>B58035U5205M062</u> <u>B58035U5305M062</u> <u>B58035U7105M062</u> <u>B58035U7155M062</u> <u>B58035U9504M062</u> <u>B58035U9754M062</u> <u>B58035U5205M052</u> <u>B58035U5305M052</u> <u>B58035U7105M052</u> <u>B58035U7155M052</u> <u>B58035U9504M052</u> <u>B58035U9754M052</u>



OOO «ЛайфЭлектроникс" "LifeElectronics" LLC

ИНН 7805602321 КПП 780501001 P/C 40702810122510004610 ФАКБ "АБСОЛЮТ БАНК" (ЗАО) в г.Санкт-Петербурге К/С 3010181090000000703 БИК 044030703

Компания «Life Electronics» занимается поставками электронных компонентов импортного и отечественного производства от производителей и со складов крупных дистрибьюторов Европы, Америки и Азии.

С конца 2013 года компания активно расширяет линейку поставок компонентов по направлению коаксиальный кабель, кварцевые генераторы и конденсаторы (керамические, пленочные, электролитические), за счёт заключения дистрибьюторских договоров

#### Мы предлагаем:

- Конкурентоспособные цены и скидки постоянным клиентам.
- Специальные условия для постоянных клиентов.
- Подбор аналогов.
- Поставку компонентов в любых объемах, удовлетворяющих вашим потребностям.
- Приемлемые сроки поставки, возможна ускоренная поставка.
- Доставку товара в любую точку России и стран СНГ.
- Комплексную поставку.
- Работу по проектам и поставку образцов.
- Формирование склада под заказчика.
- Сертификаты соответствия на поставляемую продукцию (по желанию клиента).
- Тестирование поставляемой продукции.
- Поставку компонентов, требующих военную и космическую приемку.
- Входной контроль качества.
- Наличие сертификата ISO.

В составе нашей компании организован Конструкторский отдел, призванный помогать разработчикам, и инженерам.

Конструкторский отдел помогает осуществить:

- Регистрацию проекта у производителя компонентов.
- Техническую поддержку проекта.
- Защиту от снятия компонента с производства.
- Оценку стоимости проекта по компонентам.
- Изготовление тестовой платы монтаж и пусконаладочные работы.



Тел: +7 (812) 336 43 04 (многоканальный) Email: org@lifeelectronics.ru